

<b>Notice of References Cited</b>	Application/Control No. 10/561,731		Applicant(s)/Patent Under Reexamination BURKERT ET AL.	
	Examiner TANGELA T. CHAMBERS		Art Unit 4141	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0012380	01-2002	Hottinen et al.	375/130
*	B	US-2004/0066754	04-2004	Hottinen, Ari	370/252
*	C	US-2003/0112880	06-2003	Walton et al.	375/260
*	D	US-2004/0028157	02-2004	Aoki et al.	375/347
*	E	US-2002/0169006	11-2002	Buehrer et al.	455/562
*	F	US-6,754,473	06-2004	Choi et al.	455/101
*	G	US-2003/0148738	08-2003	Das et al.	455/67.5
*	H	US-2004/0147227	07-2004	Hamalainen et al.	455/069
*	I	US-6,754,475	06-2004	Harrison et al.	455/115.1
*	J	US-2004/0165675	08-2004	Ito et al.	375/267
*	K	US-2004/0152491	08-2004	Lobinger et al.	455/561
*	L	US-6,590,532	07-2003	Ogawa et al.	342/378
*	M	US-6,765,969	07-2004	Vook et al.	375/259

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP 1179893 A1	02-2002	European Patent	KOHNO et al.	
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
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	X				

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